

Notice of References Cited

Application/Control No.

10/576,055

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

DAVID YI

Art Unit

4173

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	EP 1715634 A1	10-2006	European Patent	TANAKA et al.	
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